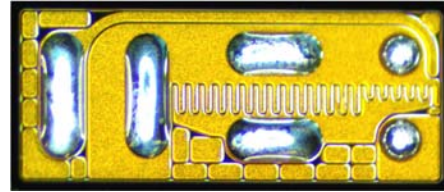


EPC8007 – Enhancement Mode Power Transistor

Preliminary Specification Sheet

Features:

- V_{DS} , 40V
- $R_{DS(on)}$, 160 m Ω
- I_D , 3.8 A
- Optimized eGaN[®] FET for high frequency applications
- Pb-Free (RoHS Compliant), Halogen Free



EPC8007 eGaN FETs are supplied only in passivated die form with solder bars

Applications:

- Ultra high speed DC-DC conversion
- RF Envelope Tracking
- Wireless Power Transfer
- Game console and industrial movement sensing (LiDAR)

MAXIMUM RATINGS

Parameter	Value
Maximum Drain – Source Voltage	40 V
Gate – Source Maximum Voltage Range	$-5\text{ V} < V_{GS} < 6\text{ V}$
Continuous Drain Current, 25 °C, $\theta_{JA} = 33$	3.8 A
Maximum Pulsed Drain Current, 25 °C, $T_{pulse} = 300\ \mu\text{s}$	6 A
Operating Temperature Range	$-40\text{ °C} < T_J < 150\text{ °C}$

STATIC CHARACTERISTICS

Parameter	Conditions	Value
Maximum Drain – Source Leakage	$V_{DS} = 32\text{ V}, V_{GS} = 0\text{ V}$	0.1 mA
Maximum $R_{DS(ON)}$	$V_{GS} = 5\text{ V}, I_D = 0.5\text{ A}$	160 m Ω
Gate – Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 0.25\text{ mA}$	$0.7\text{ V} < V_{GS(TH)} < 2.5\text{ V}$
Gate – Source Maximum Positive Leakage	$V_{GS} = 5\text{ V}$	0.5 mA
Gate – Source Maximum Negative Leakage	$V_{GS} = -5\text{ V}$	-0.1 mA

$T_J = 25\text{ °C}$ unless otherwise stated

Specifications are with Substrate shorted to Source where applicable

EPC8007 – Enhancement Mode Power Transistor Preliminary Specification Sheet



DYNAMIC CHARACTERISTICS

Parameter	Conditions	Typical Value
C_{ISS} (Input Capacitance)	$V_{DS} = 20\text{ V}; V_{GS} = 0\text{ V}$	39 pF
C_{OSS} (Output Capacitance)		14 pF
C_{RSS} (Reverse Transfer Capacitance)		0.3 pF
Q_G (Total Gate Charge)	$V_{DS} = 20\text{ V}; I_D = 1\text{ A}$	302 pC
Q_{GD} (Gate to Drain Charge)		25 pC
Q_{GS} (Gate to Source Charge)		97 pC
Q_{OSS} (Output Charge)	$V_{DS} = 20\text{ V}; V_{GS} = 0\text{ V}$	406 pC
Q_{RR} (Source-Drain Recovery Charge)		0 pC

$T_J = 25\text{ }^\circ\text{C}$ unless otherwise stated

Specifications are with Substrate shorted to Source where applicable

THERMAL CHARACTERISTICS

		TYP	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	6.7	$^\circ\text{C/W}$
$R_{\theta JB}$	Thermal Resistance, Junction to Board	33	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1)	82	$^\circ\text{C/W}$

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board.

See http://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.

EPC8007 – Enhancement Mode Power Transistor

Preliminary Specification Sheet

Figure 1:

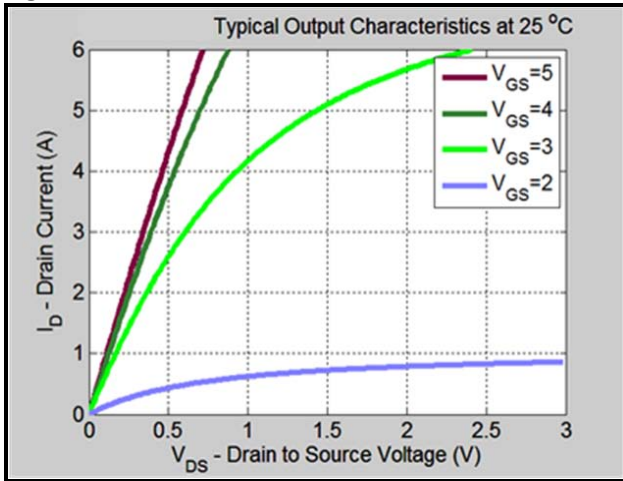


Figure 2:

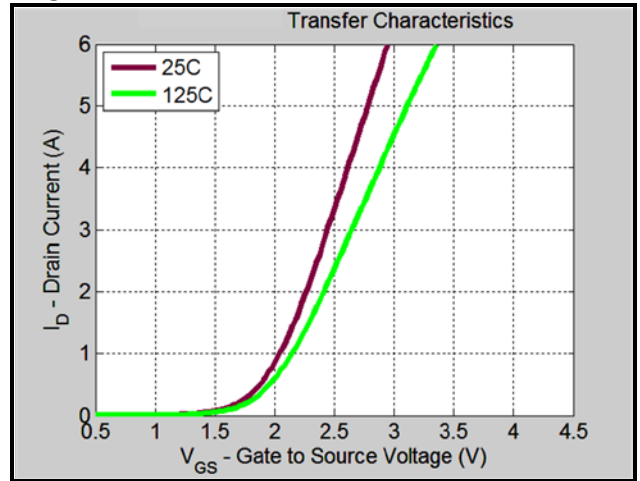


Figure 3:

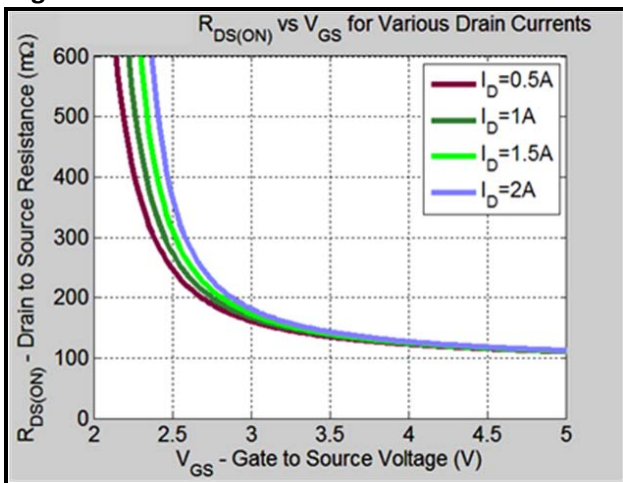


Figure 4:

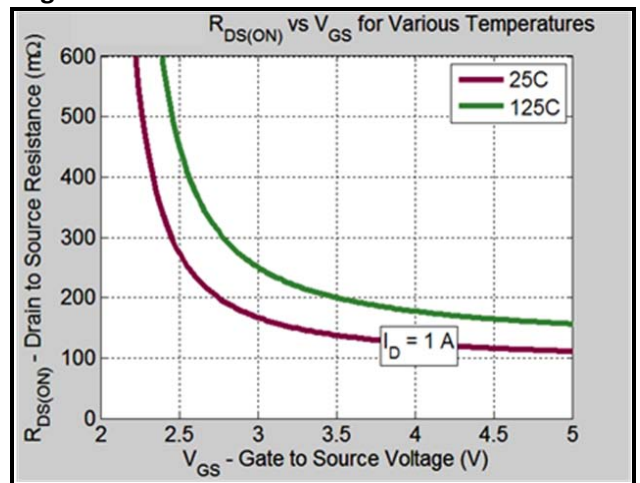
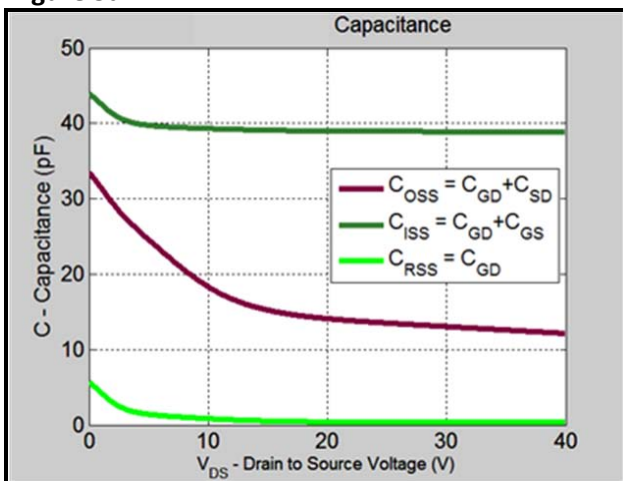
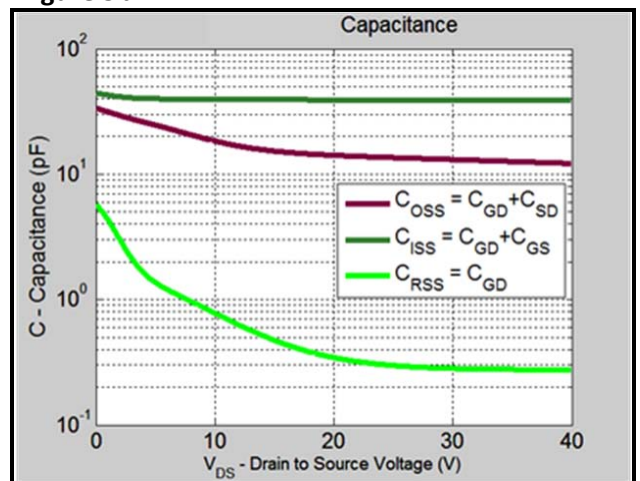


Figure 5a:



Linear Scale

Figure 5b:



Log Scale

EPC8007 – Enhancement Mode Power Transistor Preliminary Specification Sheet

Figure 6:

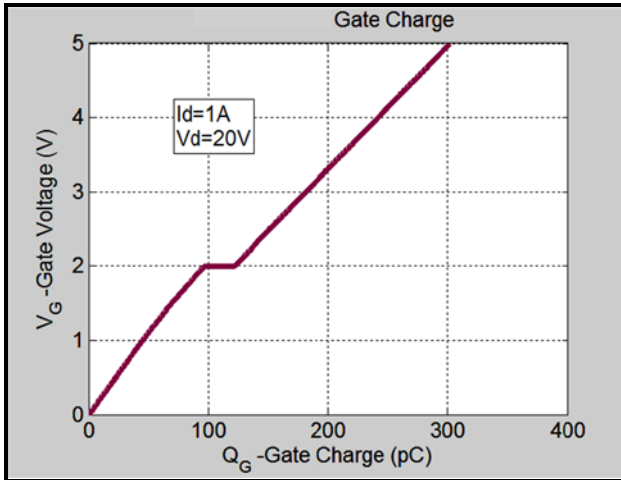


Figure 7:

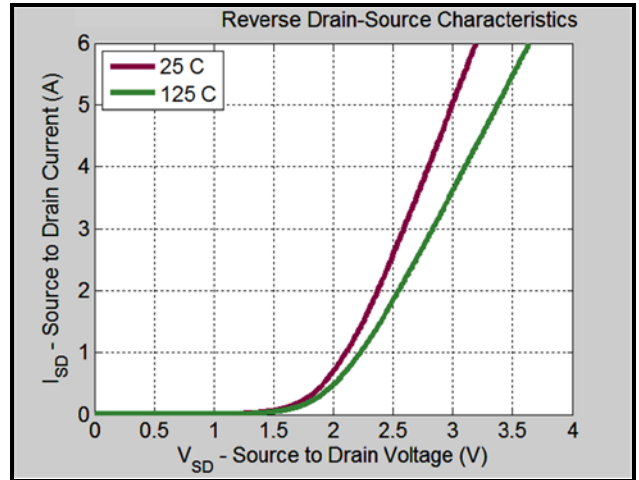


Figure 8:

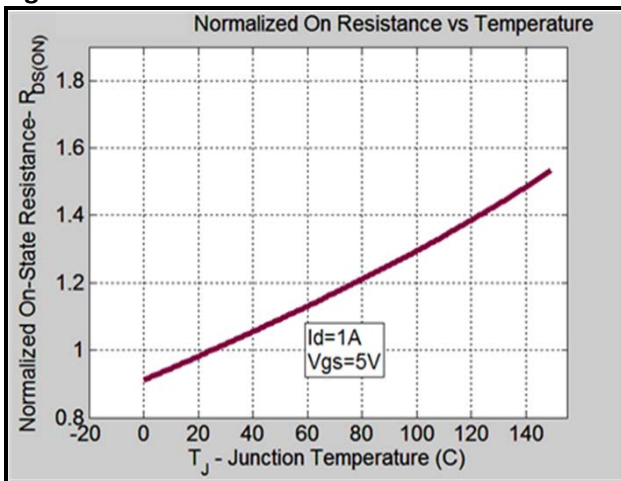
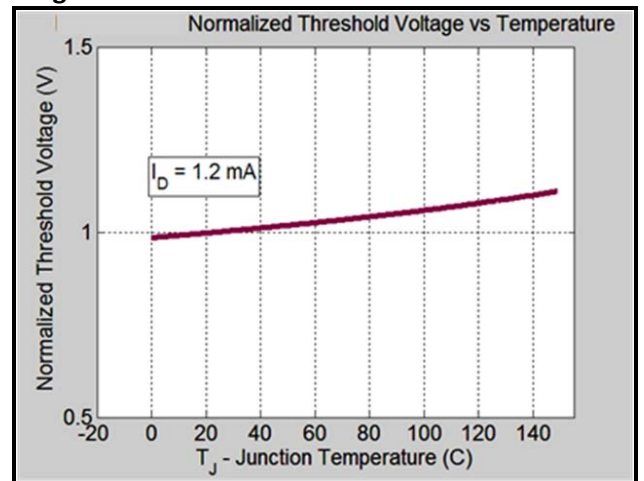


Figure 9:



All measurements were done with substrate shorted to source

EPC8007 – Enhancement Mode Power Transistor Preliminary Specification Sheet

S-PARAMETER CHARACTERISTICS

$V_{GSQ} = 1.14\text{ V}$, $V_{DSQ} = 20\text{ V}$, $I_{DQ} = 0.40\text{ A}$

Pulsed measurement, Heat-Sink Installed, $Z_0 = 50\ \Omega$

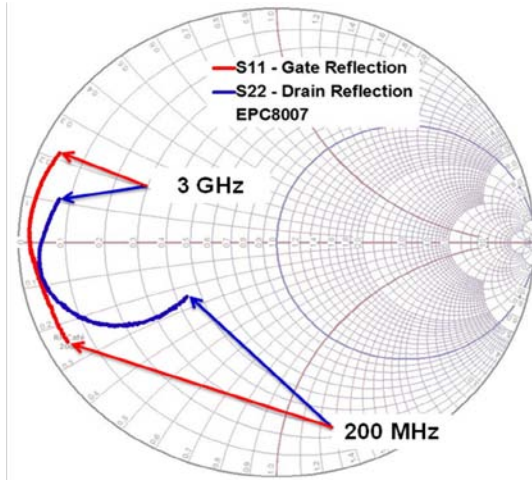


Figure 10: Smith Chart

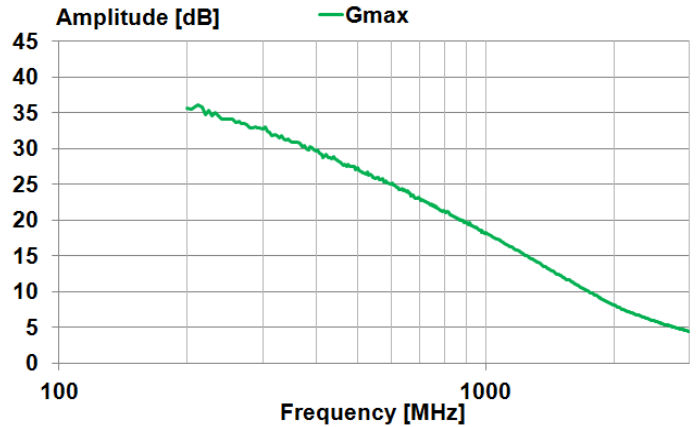


Figure 11: Gain Chart

Frequency [MHz]	Gate (Z_{GS}) [Ω]	Drain (Z_{DS}) [Ω]
200	$2.38 - j12.18$	$22.09 - j12.13$
500	$1.80 - j4.51$	$10.27 - j13.36$
1000	$1.15 - j0.60$	$3.26 - j7.31$
1200	$1.04 + j0.58$	$2.38 - j5.43$
1500	$0.97 + j2.14$	$1.95 - j2.81$
2000	$1.14 + j4.74$	$2.40 + j0.56$
2400	$1.32 + j6.84$	$2.94 + j2.64$
3000	$1.99 + j10.89$	$3.70 + j5.58$

Table 1: S-Parameter Table

Download S-parameter files at www.epc-co.com

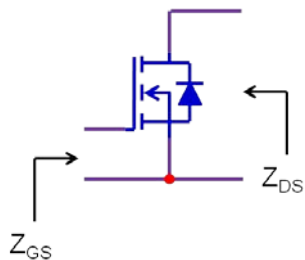


Figure 12: Device Reflection

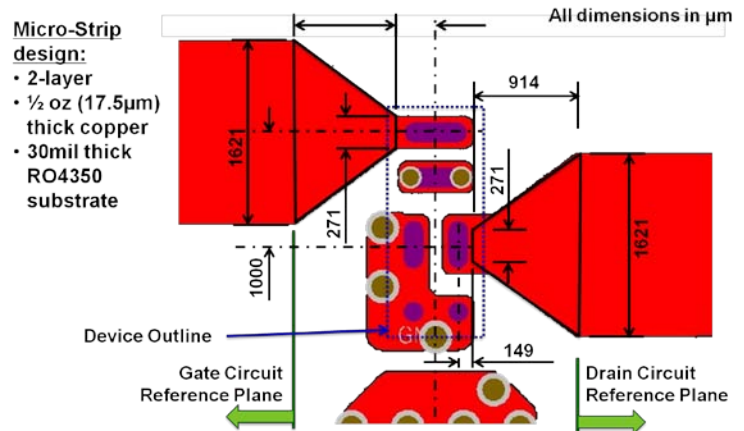
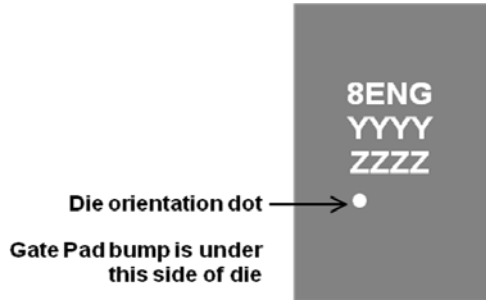


Figure 13: Taper and Reference Plane details – Device Connection

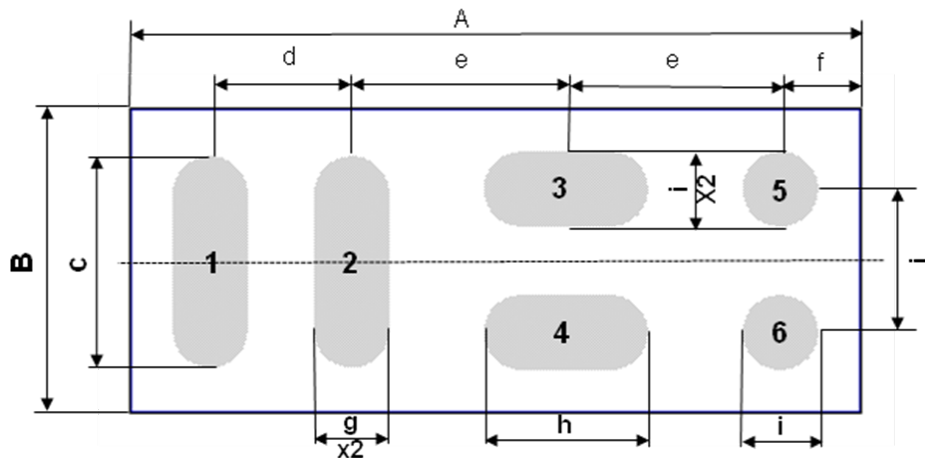
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DIE MARKINGS



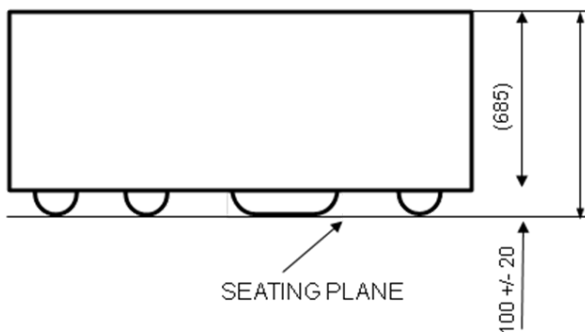
Part Number	Laser Marking		
	Part # Marking Line 1	Lot_Date Code Marking Line 2	Lot_Date Code Marking Line 3
EPC8007	8ENG	YYYY	ZZZZ

DIE OUTLINE Solder Bar View



DIM	MICROMETERS		
	MIN	Nominal	MAX
A	2020	2050	2080
B	820	850	880
c	555	580	605
d	400	400	400
e	600	600	600
f	200	225	250
g	175	200	225
h	425	450	475
i	175	200	225
j	400	400	400

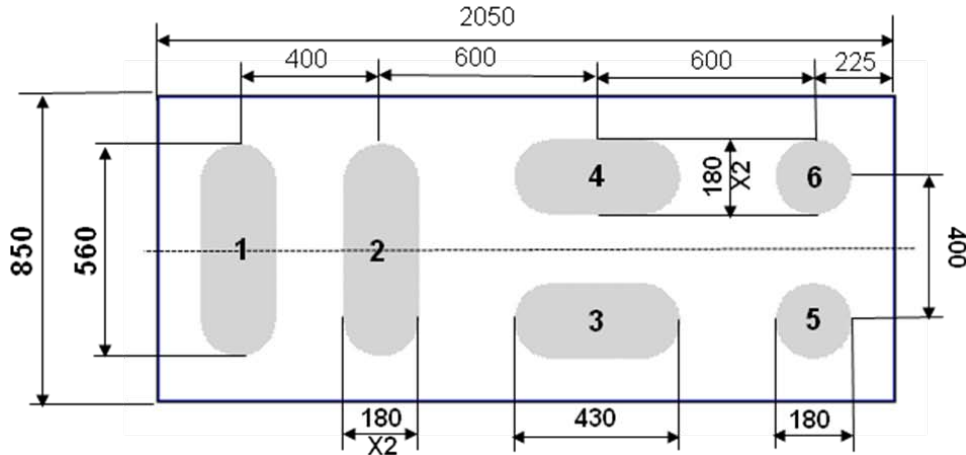
Side View



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RECOMMENDED LAND PATTERN

(units in μm)



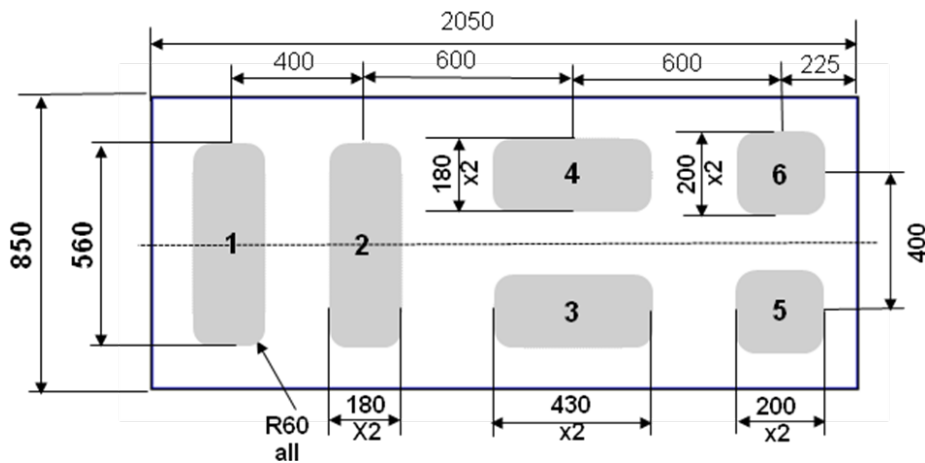
- Pad no. 1 is Gate
- Pad no. 2 is Source Return for Gate Driver
- Pad no. 3 and 5 are Source
- Pad no. 4 is Drain
- Pad no. 6 is Substrate

Land pattern is solder mask defined

Solder mask opening is 10 μm smaller per side than bump

RECOMMENDED STENCIL

(units in μm)



- Pad no. 1 is Gate
- Pad no. 2 is Source Return for Gate Driver
- Pad no. 3 and 5 are Source
- Pad no. 4 is Drain
- Pad no. 6 is Substrate

Recommended stencil should be 4mil (100 μm) thick, must be laser cut, openings per drawing.

Note that openings for pads 5 & 6 are larger than solder mask opening.

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 U.S. Patents 8,350,294; 8,404,508; 8,431,960; 8,436,398

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